Notice of References Cited

Application/Control No. 10/735,096	Reexamination	Applicant(s)/Patent Under Reexamination TSUN ET AL.	
Examiner	Art Unit		
George L. Opie	2126	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,058,490	05-2000	Allen et al.	714/9
	В	US-6,058,426	05-2000	Godwin et al.	709/229
	С	US-5,748,882	05-1998	Huang, Yennun	714/47
	D	US-5,715,386	02-1998	Fulton et al.	714/38
	E	US-5,440,726	08-1995	Fuchs et al.	714/20
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	ùs-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R	·				
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	•
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.